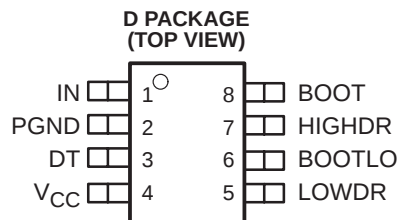


TPS2832, TPS2833 FAST SYNCHRONOUS-BUCK MOSFET DRIVER WITH DEADTIME CONTROL

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- Floating Bootstrap or Ground-Reference High-Side Driver
- Active Deadtime Control
- 50-ns Max Rise/Fall Times and 100-ns Max Propagation Delay — 3-nF Load
- Ideal for High-Current Single or Multiphase Applications
- 2.4-A Typ Peak Output Current
- 4.5-V to 15-V Supply Voltage Range
- Internal Schottky Bootstrap Diode
- Low Supply Current . . . 3-mA Typ
- –40°C to 125°C Junction-Temperature Operating Range



description

The TPS2832 and TPS2833 are MOSFET drivers for synchronous-buck power stages. These devices are ideal for designing a high-performance power supply using a switching controller that does not include suitable MOSFET drivers on the chip. The drivers are designed to deliver 2.4-A peak currents into large capacitive loads. Higher currents can be controlled by using multiple drivers in a multiphase configuration. The high-side driver can be configured as a ground-reference driver or as a floating bootstrap driver. An adaptive dead-time control circuit eliminates shoot-through currents through the main power FETs during switching transitions and provides high efficiency for the buck regulator.

The TPS2832 has a noninverting input. The TPS2833 has an inverting input. The TPS2832/33 drivers, available in 8-terminal SOIC packages, operate over a junction temperature range of –40°C to 125°C.

AVAILABLE OPTIONS

T _J	PACKAGED DEVICES
	SOIC (D)
–40°C to 125°C	TPS2832D TPS2833D

The D package is available taped and reeled. Add R suffix to device type (e.g., TPS2830DR)



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

**TEXAS
INSTRUMENTS**

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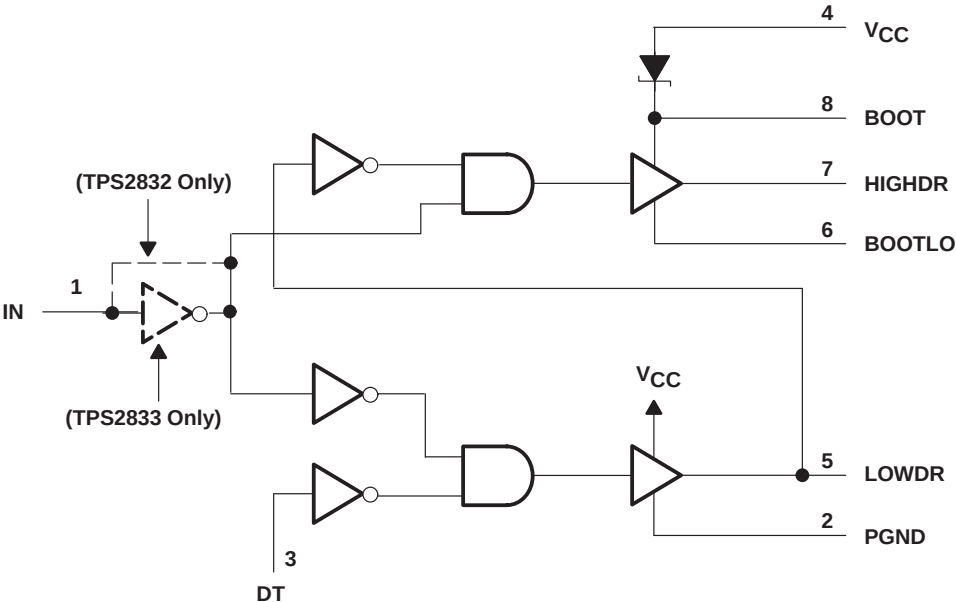
TPS2832, TPS2833

FAST SYNCHRONOUS-BUCK MOSFET DRIVER

WITH DEADTIME CONTROL

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functional block diagram



Terminal Functions

TERMINAL NAME	NO.	I/O	DESCRIPTION
BOOT	8	I	Bootstrap terminal. A ceramic capacitor is connected between BOOT and BOOTLO terminals to develop the floating bootstrap voltage for the high-side MOSFET. The capacitor value is typically between 0.1 μ F and 1 μ F. A 1-M Ω resistor should be connected across the bootstrap capacitor to provide a discharge path when the driver has been powered down.
BOOTLO	6	O	This terminal connects to the junction of the high-side and low-side MOSFETs.
DT	3	I	Deadtime control terminal. Connect DT to the junction of the high-side and low-side MOSFETs
HIGHDR	7	O	Output drive for the high-side power MOSFET
IN	1	I	Input signal to the MOSFET drivers (noninverting input for the TPS2832; inverting input for the TPS2833).
LOWDR	5	O	Output drive for the low-side power MOSFET
PGND	2		Power ground. Connect to the FET power ground.
VCC	4	I	Input supply. Recommended that a 1 μ F capacitor be connected from VCC to PGND.

detailed description

low-side driver

The low-side driver is designed to drive low $R_{ds(on)}$ N-channel MOSFETs. The current rating of the driver is 2 A, source and sink.

high-side driver

The high-side driver is designed to drive low $R_{ds(on)}$ N-channel MOSFETs. The current rating of the driver is 2 A, source and sink. The high-side driver can be configured as a ground-reference driver or a floating bootstrap driver. The internal bootstrap diode, is a Schottky for improved drive efficiency. The maximum voltage that can be applied between the BOOT terminal and ground is 30 V.

deadtime (DT) control[†]

Deadtime control prevents shoot through current from flowing through the main power FETs during switching transitions by controlling the turn-on times of the MOSFET drivers. The high-side driver is not allowed to turn on until the gate drive voltage to the low-side FET is low, and the low-side driver is not allowed to turn on until the voltage at the junction of the power FETs (V_{drn}) is low; the DT terminal connects to the junction of the power FETs.

IN[†]

The IN terminal is a digital terminal that is the input control signal for the drivers. The TPS2832 has a noninverting input; the TPS2833 has an inverting input.

[†]High-level input voltages on IN and DT must be greater than or equal to V_{CC} .

TPS2832, TPS2833

FAST SYNCHRONOUS-BUCK MOSFET DRIVER WITH DEADTIME CONTROL

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absolute maximum ratings over operating free-air temperature (unless otherwise noted)[†]

Supply voltage range, V_{CC} (see Note 1)	–0.3 V to 16 V
Input voltage range: BOOT to PGND (high-side driver ON)	–0.3 V to 30 V
BOOTLO to PGND	–0.3 V to 16 V
BOOT to BOOTLO	–0.3 V to 16 V
IN (see Note 2)	–0.3 V to 16 V
DT (see Note 2)	–0.3 V to 30 V
Continuous total power dissipation	See Dissipation Rating Table
Operating virtual junction temperature range, T_J	–40°C to 125°C
Storage temperature range, T_{stg}	–65°C to 150°C
Lead temperature soldering 1,6 mm (1/16 inch) from case for 10 seconds	260°C

[†] Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. Unless otherwise specified, all voltages are with respect to PGND.
2. High-level input voltages on the IN and DT terminals must be greater than or equal to V_{CC} .

DISSIPATION RATING TABLE

PACKAGE	$T_A \leq 25^\circ\text{C}$ POWER RATING	DERATING FACTOR ABOVE $T_A = 25^\circ\text{C}$	$T_A = 70^\circ\text{C}$ POWER RATING	$T_A = 85^\circ\text{C}$ POWER RATING
D	580 mW	5.8 mW/°C	320 mW	232 mW

recommended operating conditions

	MIN	NOM	MAX	UNIT
Supply voltage, V_{CC}	4.5		15	V
Input voltage BOOT to PGND	4.5		28	V

electrical characteristics over recommended operating virtual junction temperature range, $V_{CC} = 6.5$ V, $C_L = 3.3$ nF (unless otherwise noted)

supply current

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
V_{CC} Supply voltage range		4.5		15	V
V_{CC} Quiescent current	$V_{CC} = 15$ V			100	μA
	$V_{CC} = 12$ V, $f_{SWX} = 200$ kHz, $C_{HIGHDR} = 50$ pF, BOOTLO grounded, $C_{LOWDR} = 50$ pF, See Note 3		3		mA

NOTE 3: Ensured by design, not production tested.

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**electrical characteristics over recommended operating virtual junction temperature range,
 $V_{CC} = 6.5\text{ V}$, $C_L = 3.3\text{ nF}$ (unless otherwise noted) (continued)**

output drivers

PARAMETER			TEST CONDITIONS	MIN	TYP	MAX	UNIT
Peak output-current	High-side sink (see Note 4)	Duty cycle < 2%, $t_{pw} < 100\text{ }\mu\text{s}$ (see Note 3)	$V_{BOOT} - V_{BOOTLO} = 4.5\text{ V}$, $V_{HIGHDR} = 4\text{ V}$	0.7	1.1		A
			$V_{BOOT} - V_{BOOTLO} = 6.5\text{ V}$, $V_{HIGHDR} = 5\text{ V}$	1.1	1.5		
			$V_{BOOT} - V_{BOOTLO} = 12\text{ V}$, $V_{HIGHDR} = 10.5\text{ V}$	2	2.4		
	High-side source (see Note 4)	Duty cycle < 2%, $t_{pw} < 100\text{ }\mu\text{s}$ (see Note 3)	$V_{BOOT} - V_{BOOTLO} = 4.5\text{ V}$, $V_{HIGHDR} = 0.5\text{ V}$	1.2	1.4		A
			$V_{BOOT} - V_{BOOTLO} = 6.5\text{ V}$, $V_{HIGHDR} = 1.5\text{ V}$	1.3	1.6		
			$V_{BOOT} - V_{BOOTLO} = 12\text{ V}$, $V_{HIGHDR} = 1.5\text{ V}$	2.3	2.7		
	Low-side sink (see Note 4)	Duty cycle < 2%, $t_{pw} < 100\text{ }\mu\text{s}$ (see Note 3)	$V_{CC} = 4.5\text{ V}$, $V_{LOWDR} = 4\text{ V}$	1.3	1.8		A
			$V_{CC} = 6.5\text{ V}$, $V_{LOWDR} = 5\text{ V}$	2	2.5		
			$V_{CC} = 12\text{ V}$, $V_{LOWDR} = 10.5\text{ V}$	3	3.5		
	Low-side source (see Note 4)	Duty cycle < 2%, $t_{pw} < 100\text{ }\mu\text{s}$ (see Note 3)	$V_{CC} = 4.5\text{ V}$, $V_{LOWDR} = 0.5\text{ V}$	1.4	1.7		A
			$V_{CC} = 6.5\text{ V}$, $V_{LOWDR} = 1.5\text{ V}$	2	2.4		
			$V_{CC} = 12\text{ V}$, $V_{LOWDR} = 1.5\text{ V}$	2.5	3		
Output resistance	High-side sink (see Note 4)		$V_{BOOT} - V_{BOOTLO} = 4.5\text{ V}$, $V_{HIGHDR} = 0.5\text{ V}$			5	Ω
			$V_{BOOT} - V_{BOOTLO} = 6.5\text{ V}$, $V_{HIGHDR} = 0.5\text{ V}$			5	
			$V_{BOOT} - V_{BOOTLO} = 12\text{ V}$, $V_{HIGHDR} = 0.5\text{ V}$			5	
	High-side source (see Note 4)		$V_{BOOT} - V_{BOOTLO} = 4.5\text{ V}$, $V_{HIGHDR} = 4\text{ V}$			45	Ω
			$V_{BOOT} - V_{BOOTLO} = 6.5\text{ V}$, $V_{HIGHDR} = 6\text{ V}$			45	
			$V_{BOOT} - V_{BOOTLO} = 12\text{ V}$, $V_{HIGHDR} = 11.5\text{ V}$			45	
	Low-side sink (see Note 4)		$V_{DRV} = 4.5\text{ V}$, $V_{LOWDR} = 0.5\text{ V}$			9	Ω
			$V_{DRV} = 6.5\text{ V}$, $V_{LOWDR} = 0.5\text{ V}$			7.5	
			$V_{DRV} = 12\text{ V}$, $V_{LOWDR} = 0.5\text{ V}$			6	
	Low-side source (see Note 4)		$V_{DRV} = 4.5\text{ V}$, $V_{LOWDR} = 4\text{ V}$			45	Ω
			$V_{DRV} = 6.5\text{ V}$, $V_{LOWDR} = 6\text{ V}$			45	
			$V_{DRV} = 12\text{ V}$, $V_{LOWDR} = 11.5\text{ V}$			45	

NOTES: 3. Ensured by design, not production tested.

4. The pull-up/pull-down circuits of the drivers are bipolar and MOSFET transistors in parallel. The peak output current rating is the combined current from the bipolar and MOSFET transistors. The output resistance is the $R_{ds(on)}$ of the MOSFET transistor when the voltage on the driver output is less than the saturation voltage of the bipolar transistor.

deadtime

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
LOWDR	High-level input voltage	Over the V_{CC} range (see Note 3)	2			V
	Low-level input voltage				1	V
DT	High-level input voltage	Over the V_{CC} range	2			V
	Low-level input voltage				1	V

NOTE 3: Ensured by design, not production tested.

digital control terminals

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
High-level input voltage	Over the V_{CC} range	2			V
Low-level input voltage				1	V



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switching characteristics over recommended operating virtual junction temperature range,
 $C_L = 3.3 \text{ nF}$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
Rise time	HIGHDR output (see Note 3)	$V_{BOOT} = 4.5 \text{ V}$, $V_{BOOTLO} = 0 \text{ V}$			60	ns
		$V_{BOOT} = 6.5 \text{ V}$, $V_{BOOTLO} = 0 \text{ V}$			50	
		$V_{BOOT} = 12 \text{ V}$, $V_{BOOTLO} = 0 \text{ V}$			50	
	LOWDR output (see Note 3)	$V_{CC} = 4.5 \text{ V}$			40	ns
		$V_{CC} = 6.5 \text{ V}$			30	
		$V_{CC} = 12 \text{ V}$			30	
Fall time	HIGHDR output (see Note 3)	$V_{BOOT} = 4.5 \text{ V}$, $V_{BOOTLO} = 0 \text{ V}$			60	ns
		$V_{BOOT} = 6.5 \text{ V}$, $V_{BOOTLO} = 0 \text{ V}$			50	
		$V_{BOOT} = 12 \text{ V}$, $V_{BOOTLO} = 0 \text{ V}$			50	
	LOWDR output (see Note 3)	$V_{CC} = 4.5 \text{ V}$			40	ns
		$V_{CC} = 6.5 \text{ V}$			30	
		$V_{CC} = 12 \text{ V}$			30	
Propagation delay time	HIGHDR going low (excluding deadtime) (see Note 3)	$V_{BOOT} = 4.5 \text{ V}$, $V_{BOOTLO} = 0 \text{ V}$			130	ns
		$V_{BOOT} = 6.5 \text{ V}$, $V_{BOOTLO} = 0 \text{ V}$			100	
		$V_{BOOT} = 12 \text{ V}$, $V_{BOOTLO} = 0 \text{ V}$			75	
	LOWDR going high (excluding deadtime) (see Note 3)	$V_{BOOT} = 4.5 \text{ V}$, $V_{BOOTLO} = 0 \text{ V}$			80	ns
		$V_{BOOT} = 6.5 \text{ V}$, $V_{BOOTLO} = 0 \text{ V}$			70	
		$V_{BOOT} = 12 \text{ V}$, $V_{BOOTLO} = 0 \text{ V}$			60	
Propagation delay time	LOWDR going low (excluding deadtime) (see Note 3)	$V_{CC} = 4.5 \text{ V}$			80	ns
		$V_{CC} = 6.5 \text{ V}$			70	
		$V_{CC} = 12 \text{ V}$			60	
Driver nonoverlap time	DT to LOWDR and LOWDR to HIGHDR (see Note 3)	$V_{CC} = 4.5 \text{ V}$	40		170	ns
		$V_{CC} = 6.5 \text{ V}$	25		135	
		$V_{CC} = 12 \text{ V}$	15		85	

NOTE 3: Ensured by design, not production tested.

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FAST SYNCHRONOUS-BUCK MOSFET DRIVER
WITH DEADTIME CONTROL

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TYPICAL CHARACTERISTICS

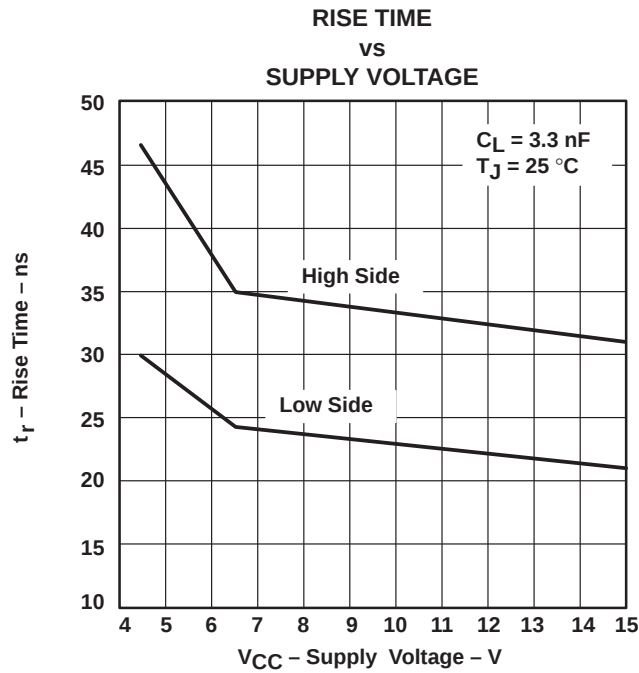


Figure 1

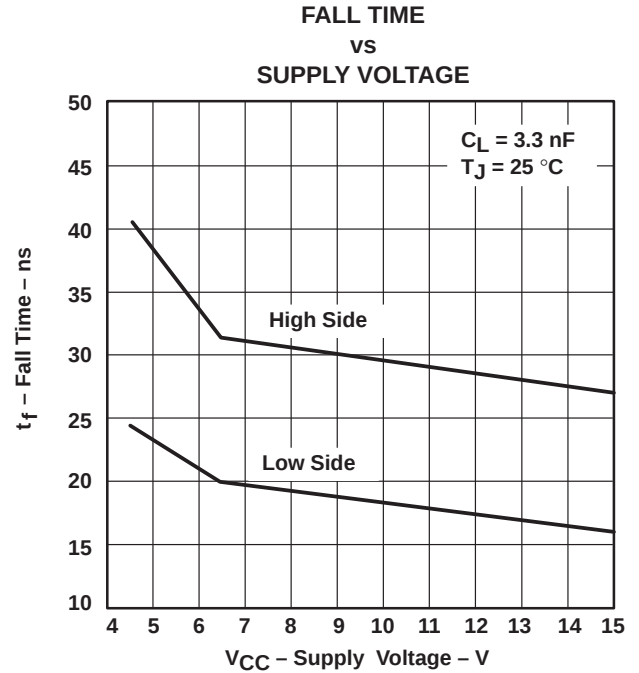


Figure 2

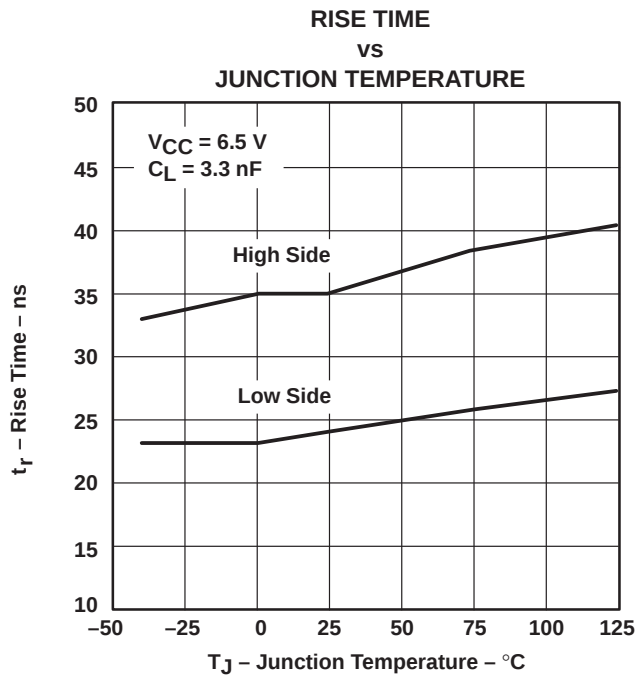


Figure 3

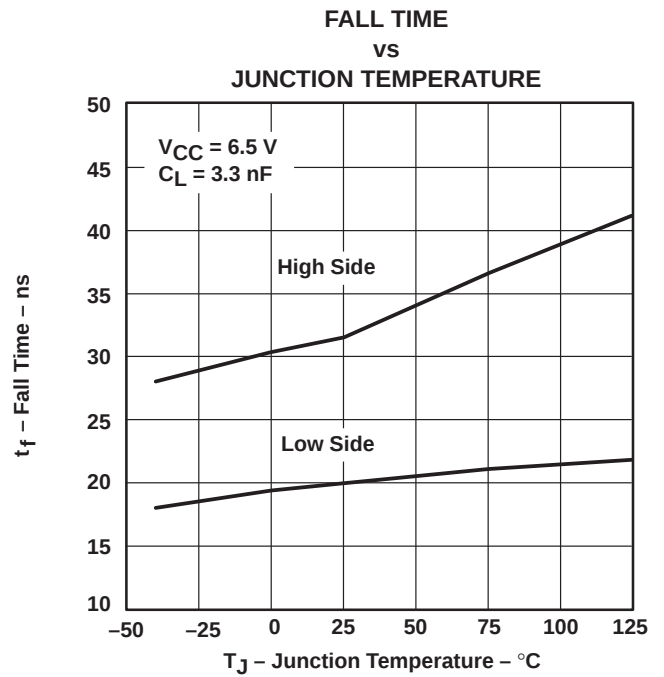


Figure 4

TPS2832, TPS2833

FAST SYNCHRONOUS-BUCK MOSFET DRIVER

WITH DEADTIME CONTROL

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TYPICAL CHARACTERISTICS

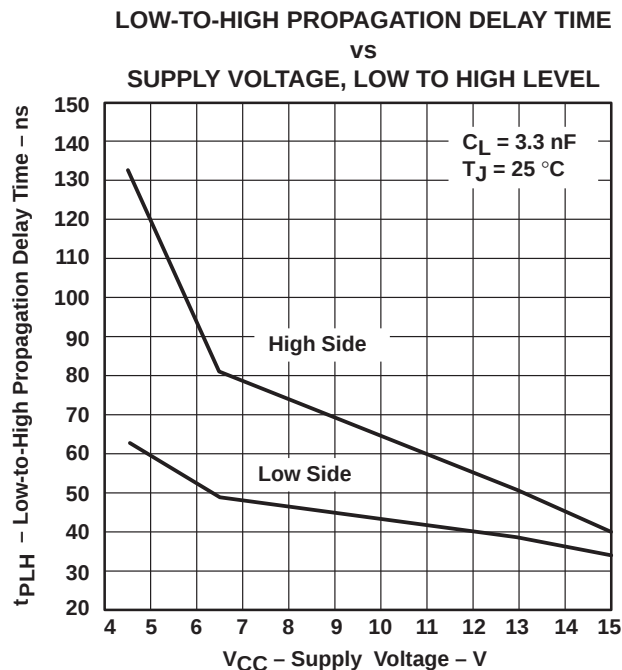


Figure 5

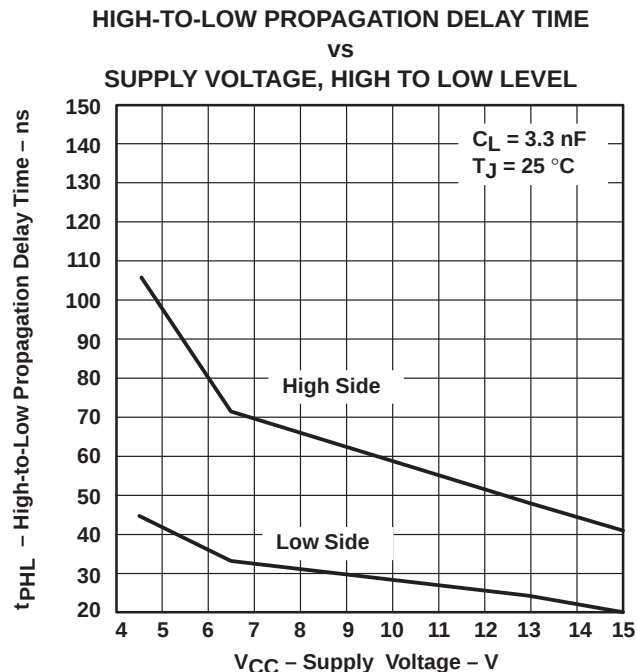


Figure 6

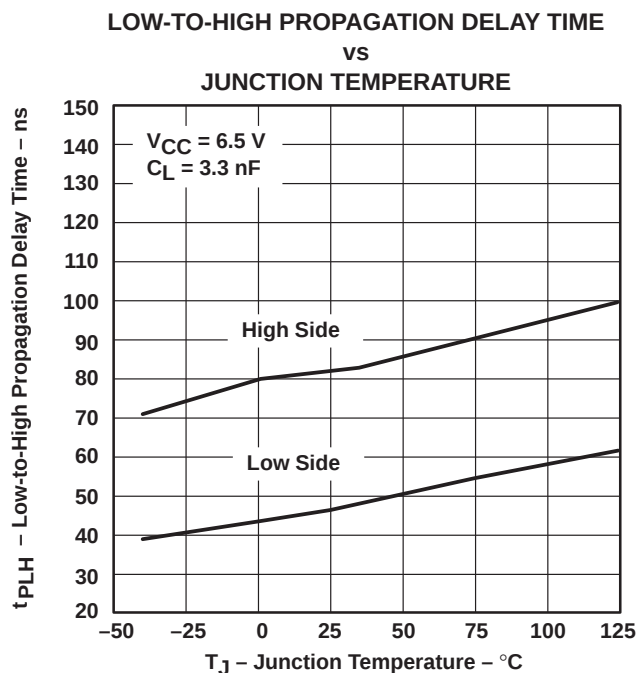


Figure 7

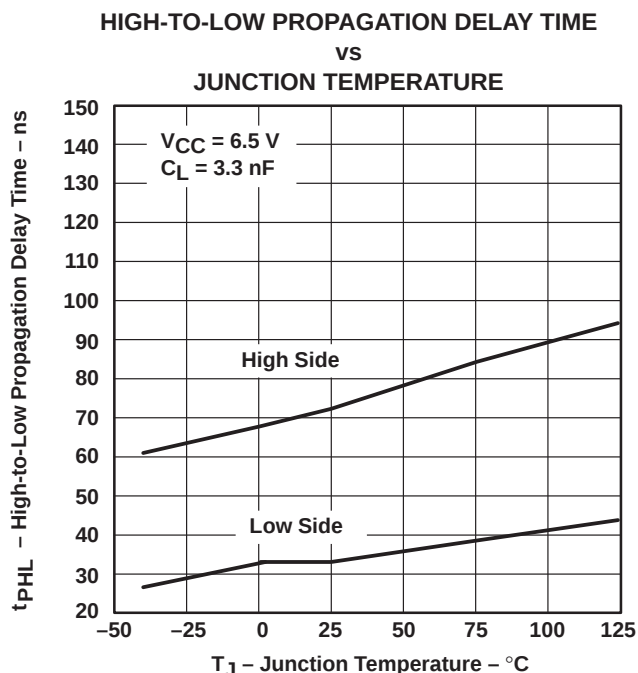


Figure 8

TPS2832, TPS2833 FAST SYNCHRONOUS-BUCK MOSFET DRIVER WITH DEADTIME CONTROL

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TYPICAL CHARACTERISTICS

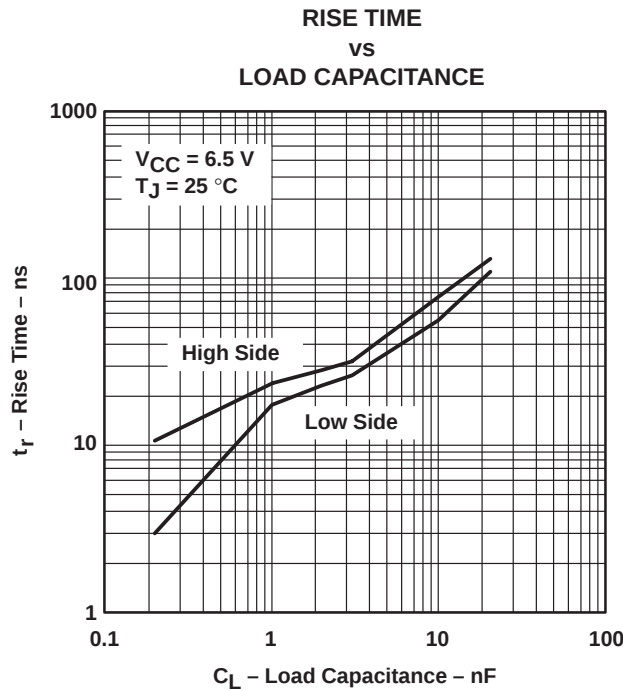


Figure 9

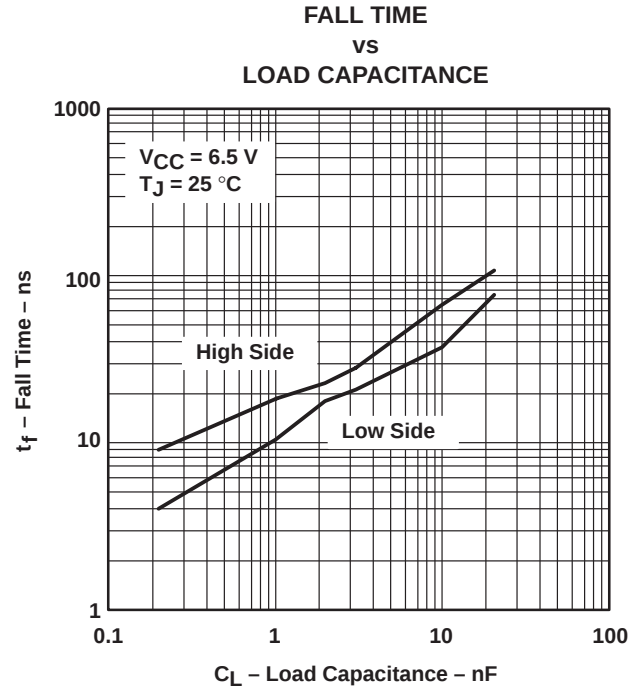


Figure 10

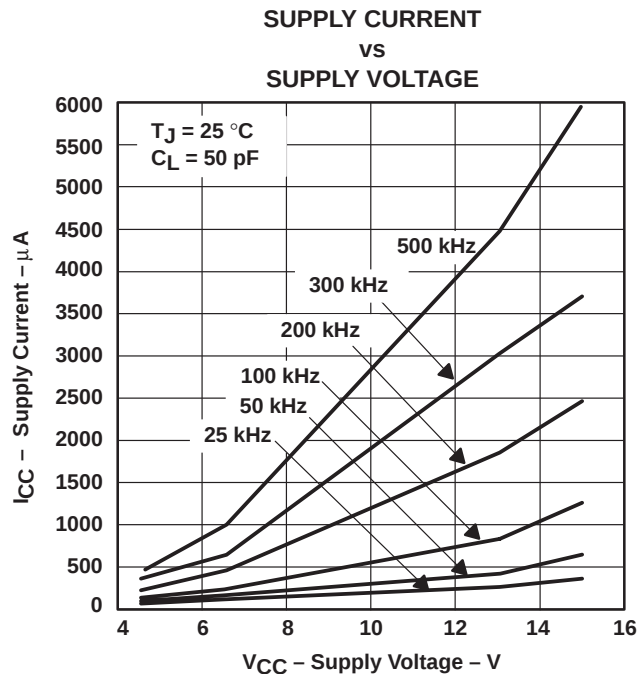


Figure 11

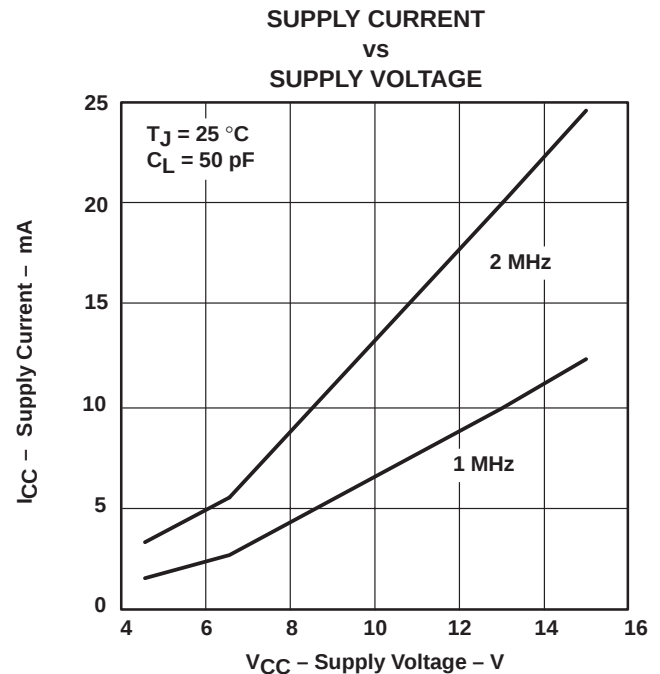


Figure 12

TPS2832, TPS2833

FAST SYNCHRONOUS-BUCK MOSFET DRIVER

WITH DEADTIME CONTROL

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TYPICAL CHARACTERISTICS

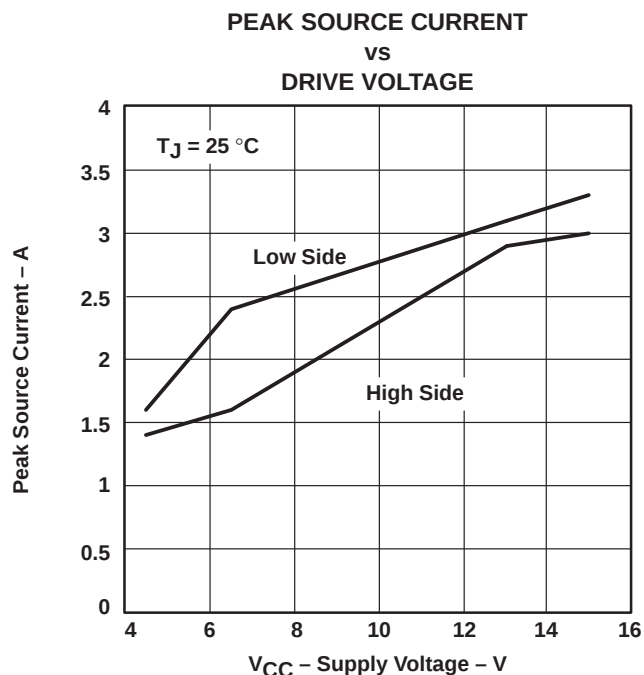


Figure 13

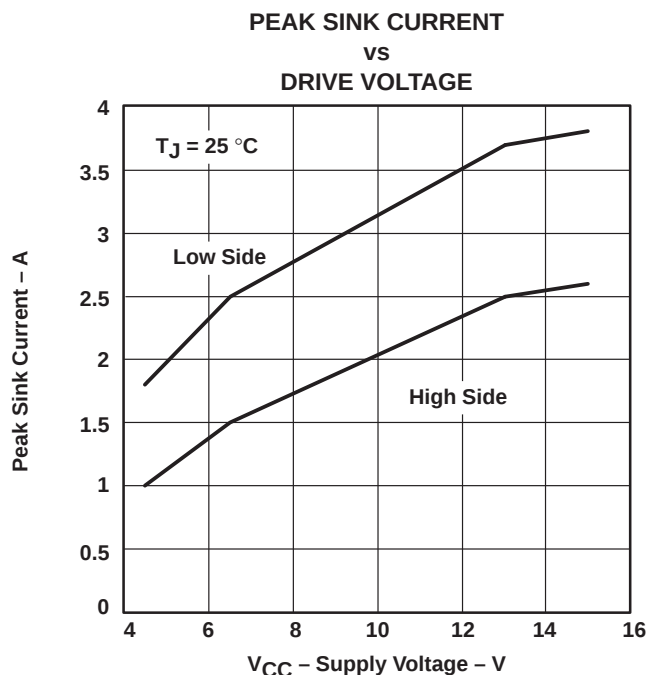


Figure 14

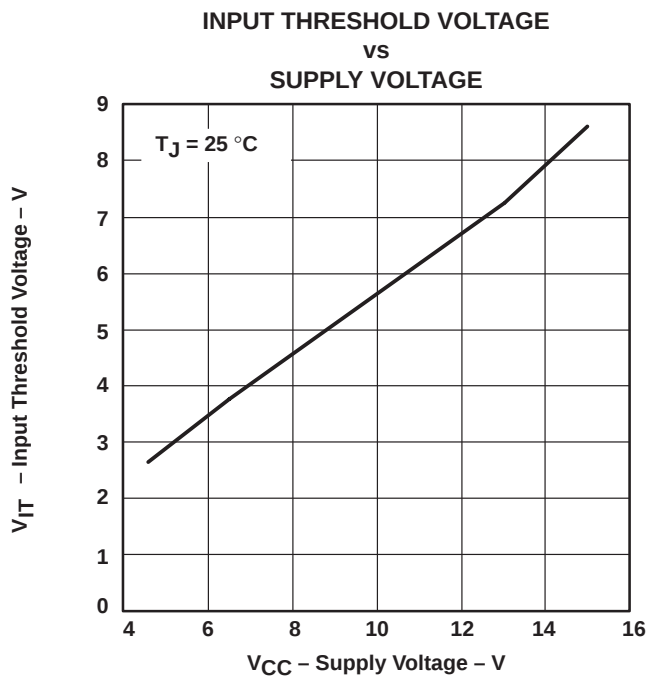


Figure 15

TPS2832, TPS2833 FAST SYNCHRONOUS-BUCK MOSFET DRIVER WITH DEADTIME CONTROL

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APPLICATION INFORMATION

Figure 15 shows the circuit schematic of a 100-kHz synchronous-buck converter implemented with a TL5001A pulse-width-modulation (PWM) controller and a TPS2833 driver. The converter operates over an input range from 4.5 V to 12 V and has a 3.3 V output. The circuit can supply 3 A continuous load and the transient load is 5 A. The converter achieves an efficiency of 94% for $V_{IN} = 5$ V, $I_{load} = 1$ A, and 93% for $V_{IN} = 5$ V, $I_{load} = 3$ A.

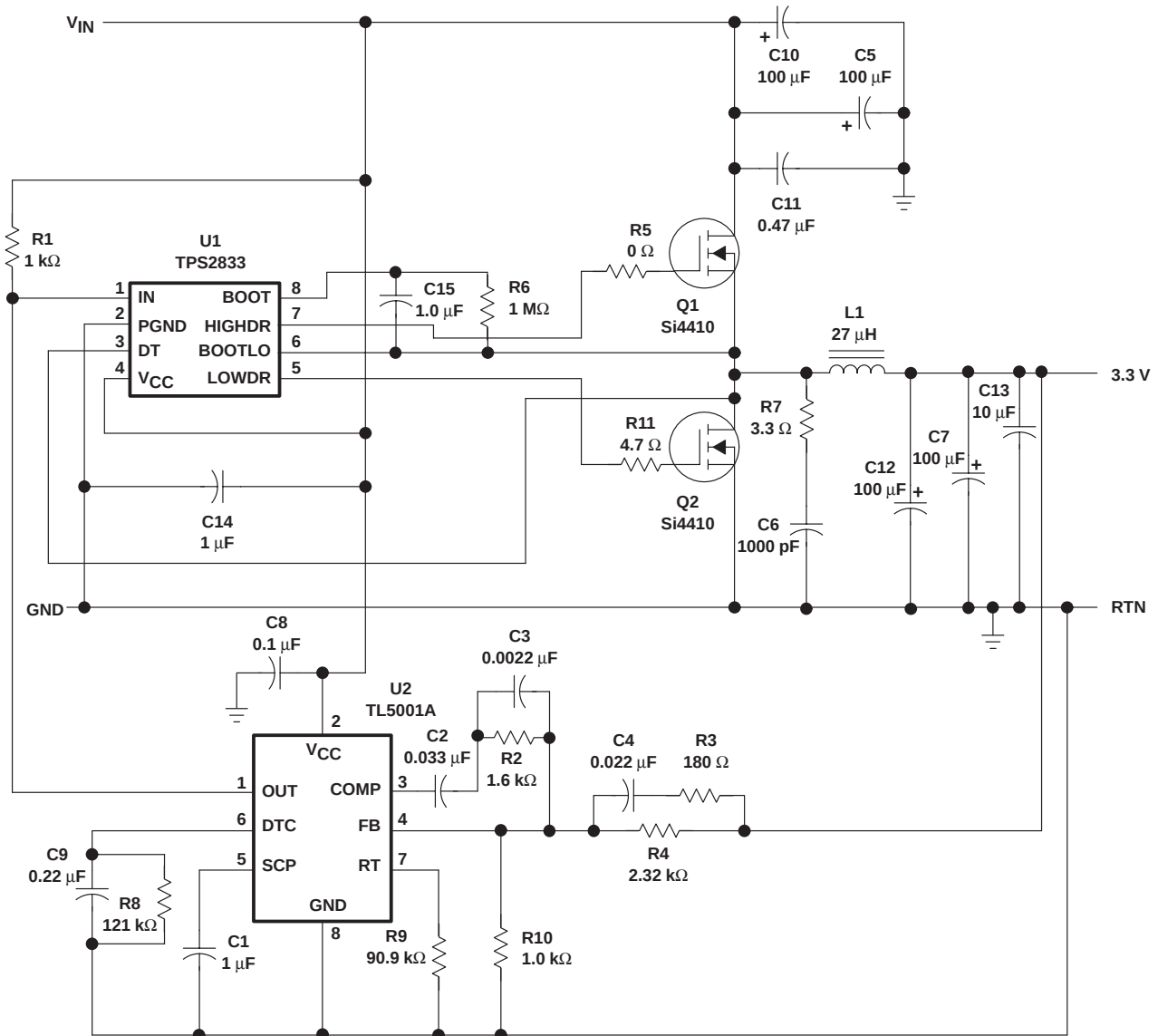


Figure 16. 3.3 V 3 A Synchronous-Buck Converter Circuit

TPS2832, TPS2833

FAST SYNCHRONOUS-BUCK MOSFET DRIVER WITH DEADTIME CONTROL

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APPLICATION INFORMATION

Great care should be taken when laying out the pc board. The power-processing section is the most critical and will generate large amounts of EMI if not properly configured. The junction of Q1, Q2, and L1 should be very tight. The connection from Q1 drain to the positive sides of C5, C10, and C11 and the connection from Q2 source to the negative sides of C5, C10, and C11 should be as short as possible. The negative terminals of C7 and C12 should also be connected to Q2 source.

Next, the traces from the MOSFET driver to the power switches should be considered. The BOOTLO signal from the junction of Q1 and Q2 carries the large gate drive current pulses and should be as heavy as the gate drive traces. The bypass capacitor (C14) should be tied directly across V_{CC} and PGND.

The next most sensitive node is the FB node on the controller (terminal 4 on the TL5001A) This node is very sensitive to noise pick up and should be isolated from the high-current power stage and be as short as possible. The ground around the controller and low-level circuitry should be tied to the power ground as the output. If these three areas are properly laid out, the rest of the circuit should not have any other EMI problems and the power supply will be relatively free of noise.



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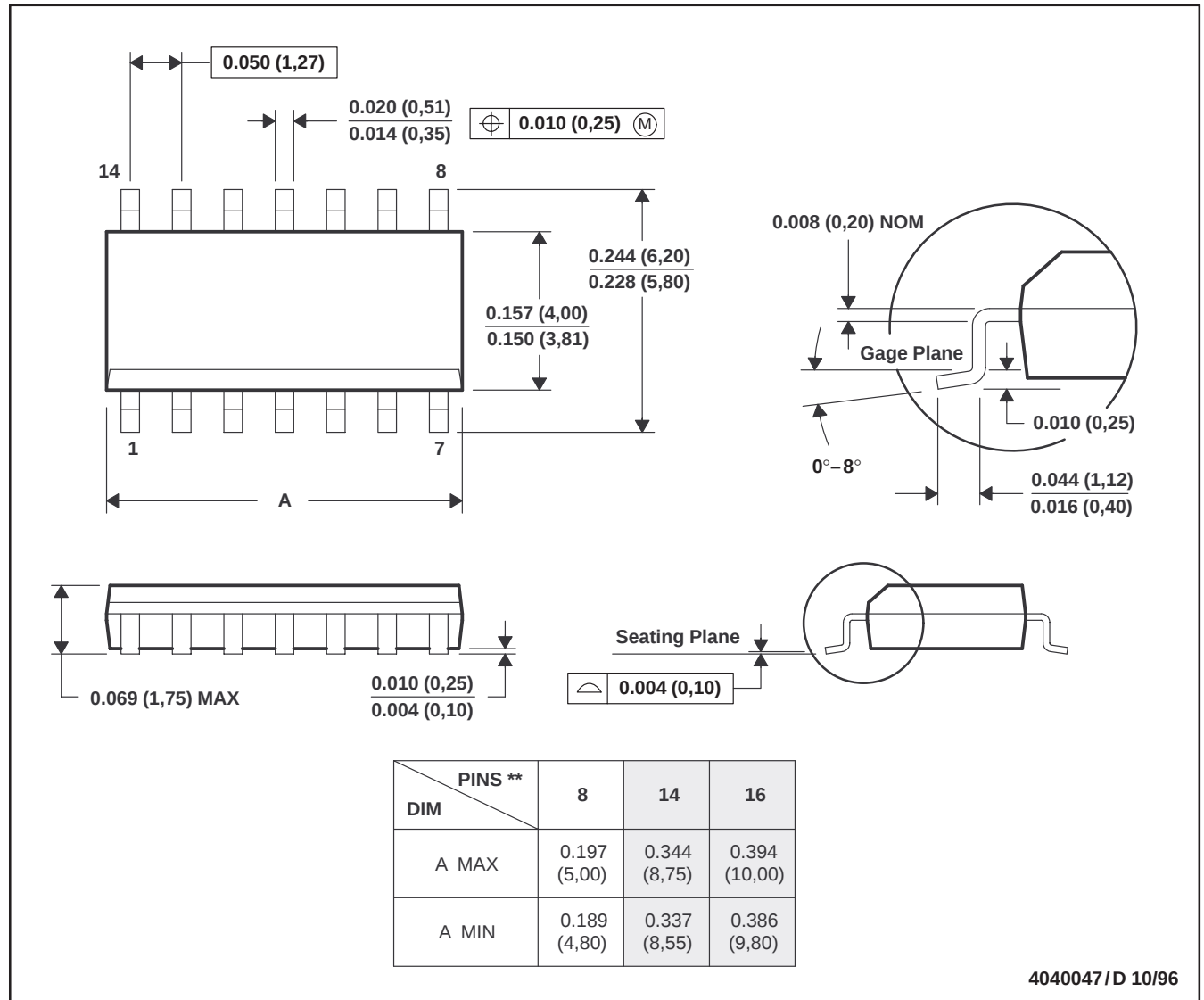
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MECHANICAL DATA

D (R-PDSO-G)**

PLASTIC SMALL-OUTLINE PACKAGE

14 PIN SHOWN



- NOTES: A. All linear dimensions are in inches (millimeters).
 B. This drawing is subject to change without notice.
 C. Body dimensions do not include mold flash or protrusion, not to exceed 0.006 (0,15).
 D. Falls within JEDEC MS-012

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